Docket No.: 052775-0024 **PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Igre Application of

Customer Number: 20277

Masahiro NAKAYAMA, et al.

Confirmation Number: 1716

Application No.: 10/662,524

Group Art Unit: 2826

Filed: September 16, 2003

Examiner: QUINTO, KEVIN V

For: CHAMFERED FREESTANDING NITRIDE SEMICONDUCTOR WAFER AND

METHOD OF CHAMFERING NITRIDE SEMICONDUCTOR WAFER

## INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Each non-English language reference was first cited in a corresponding foreign application office action and its relevance discussed therein. A copy of the foreign office action, is attached for the Examiner's information.

## 10/662,524

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Facsimile: 202.756.8087 **Date: July 18, 2005** 

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